

# Am25LS07/Am25LS08

Hex/Quad Parallel D Registers with Register Enable

## DISTINCTIVE CHARACTERISTICS

- 4-bit and 6-bit parallel registers
- Common Clock and Common Enable
- Positive edge triggered D flip flops
- Second sourced by TI as 54LS/74LS378 and 379
- Am25LS D.C. parameters including:  
 $V_{OL} = 0.45V$  at  $I_{OL} = 8mA$   
 Fan-out over military range = 22  
 $440\mu A$  source current

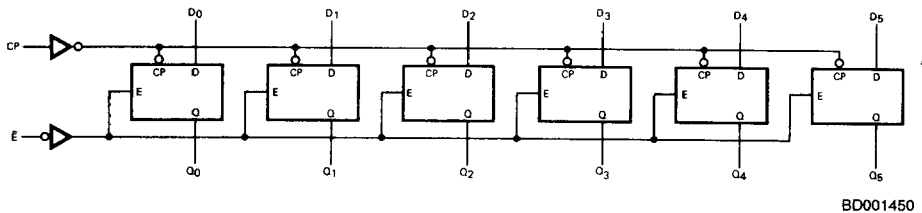
## GENERAL DESCRIPTION

The Am25LS07 is a 6-bit Low Power Schottky register with a buffered common register enable. The Am25LS08 is a 4-bit register with a buffered common register enable. The devices are similar to the Am54LS/74LS174 and Am54LS/74LS175 but feature the common register enable rather than common clear.

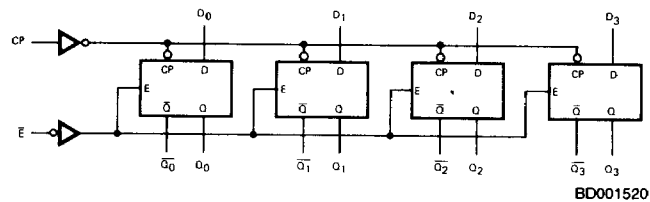
Both registers will find application in digital systems where information is associated with a logic gating signal. When the enable is LOW, data on the D inputs is stored in the register on the positive going edge of the clock pulse. When the enable is HIGH, the register will not change state regardless of the clock or data input transitions.

## BLOCK DIAGRAM

Am25LS07



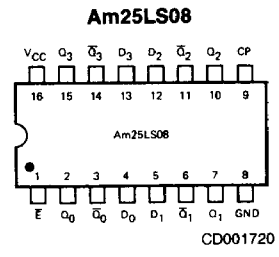
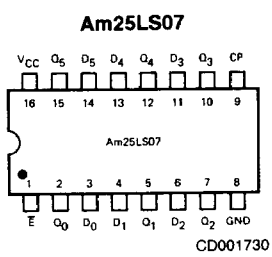
Am25LS08



## RELATED PRODUCTS

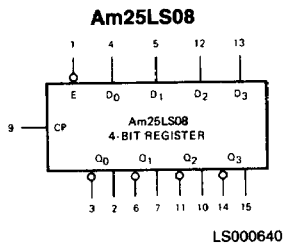
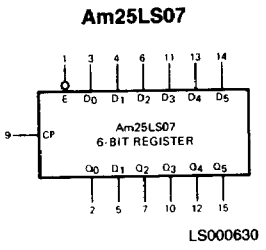
Part No.	Description
Am2918	Quad D Register
Am2919	Quad D Register

### CONNECTION DIAGRAM Top View



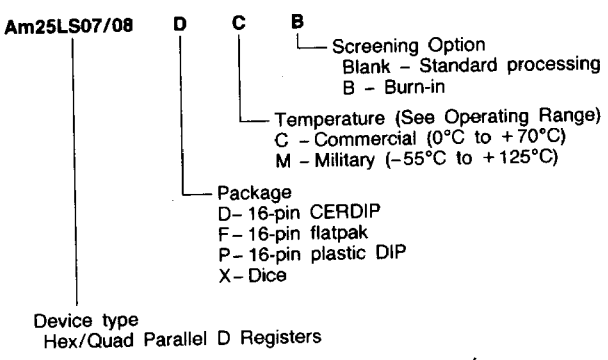
Note: Pin 1 is marked for orientation

### LOGIC SYMBOL



### ORDERING INFORMATION

AMD products are available in several packages and operating ranges. The order number is formed by a combination of the following: Device number, speed option (if applicable), package type, operating range and screening option (if desired).



Valid Combinations	
Am25LS07/08	PC DC, DM FM XC, XM

**Valid Combinations**  
 Consult the AMD sales office in your area to determine if a device is currently available in the combination you wish.

## PIN DESCRIPTION

Pin No.	Name	I/O	Description
	$D_i$	I	The D flip-flop data inputs.
1	$\bar{E}$	I	Enable. When the enable is LOW, data on the $D_i$ inputs is transferred to the $Q_i$ outputs on the LOW-to-HIGH clock transition. When the enable is HIGH, the $Q_i$ outputs do not change regardless of the data or clock input transitions.
9	CP	I	Clock. Pulse for the register. Enters data on the LOW-to-HIGH transition.
	$Q_i$	O	The TRUE register outputs.
	$\bar{Q}_i$	O	The complement register outputs.

## FUNCTION TABLE

Inputs			Outputs	
$\bar{E}$	$D_i$	CP	$Q_i$	$\bar{Q}_i$
H	X	X	NC	NC
L	X	H	NC	NC
L	X	L	NC	NC
L	L	↑	L	H
L	H	↑	H	L

H = HIGH NC = No Change ↑ = LOW-to-HIGH Transition  
 L = LOW X = Don't Care  $\bar{Q}_i$  on Am25LS08 Only

**ABSOLUTE MAXIMUM RATINGS**

Storage Temperature .....	-65°C to +150°C
Temperature (Ambient) Under Bias .....	-55°C to +125°C
Supply Voltage to Ground Potential (Pin 16 to Pin 8) Continuous .....	-0.5V to +7.0V
DC Voltage Applied to Outputs For HIGH Output State .....	-0.5V to +V <sub>CC</sub> max
DC Input Voltage .....	-0.5V to +7.0V
DC Output Current, Into Outputs .....	30mA
DC Input Current .....	-30mA to +5.0mA

Stresses above those listed under **ABSOLUTE MAXIMUM RATINGS** may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

**OPERATING RANGES**

## Commercial (C) Devices

Temperature .....	0°C to +70°C
Supply Voltage .....	+4.75V to +5.25V

## Military (M) Devices

Temperature .....	-55°C to +125°C
Supply Voltage .....	+4.5V to +5.5V

Operating ranges define those limits over which the functionality of the device is guaranteed.

**DC CHARACTERISTICS** over operating range unless otherwise specified

Parameters	Description	Test Conditions (Note 2)	Min	Typ (Note 1)		Max	Units
				COM'L	MIL		
V <sub>OH</sub>	Output HIGH Voltage	V <sub>CC</sub> = MIN., I <sub>OH</sub> = -440μA V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	COM'L	2.7	3.4		Volts
			MIL	2.5	3.4		
V <sub>OL</sub>	Output LOW Voltage	V <sub>CC</sub> = MIN. V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 4mA			0.4	Volts
			I <sub>OL</sub> = 8mA			0.45	
V <sub>IH</sub>	Input HIGH Level	Guaranteed input logical HIGH voltage for all inputs	2.0				Volts
V <sub>IL</sub>	Input LOW Level	Guaranteed input logical LOW voltage for all inputs	COM'L			0.8	Volts
			MIL			0.7	
V <sub>I</sub>	Input Clamp Voltage	V <sub>CC</sub> = MIN., I <sub>IN</sub> = -18mA				-1.5	Volts
I <sub>IL</sub>	Input LOW Current	V <sub>CC</sub> = MAX., V <sub>IN</sub> = 0.4V	Clock, $\bar{E}$			-0.36	mA
			Others			-0.24	
I <sub>IH</sub>	Input HIGH Current	V <sub>CC</sub> = MAX., V <sub>IN</sub> = 2.7V	Clock, $\bar{E}$			20	μA
			Others			14	
I <sub>I</sub>	Input HIGH Current	V <sub>CC</sub> = MAX., V <sub>IN</sub> = 7.0V				0.1	mA
I <sub>SC</sub>	Output Short Circuit Current (Note 3)	V <sub>CC</sub> = MAX.	-15			-85	mA
I <sub>CC</sub>	Power Supply Current	V <sub>CC</sub> = MAX. (Note 4)	LS07		16	22	mA
			LS08		11	18	

- Notes: 1. Typical limits are at V<sub>CC</sub> = 5.0V, 25°C ambient and maximum loading.  
 2. For conditions shown as MIN. or MAX., use the appropriate value specified under Operating Ranges for the applicable device type.  
 3. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.  
 4. Outputs open, enable grounded; data inputs at 4.5V, measured after a momentary ground, then 4.5V applied to the clock input.

### SWITCHING CHARACTERISTICS (T<sub>A</sub> = +25°C, V<sub>CC</sub> = 5.0V)

Parameters	Description	Test Conditions	Min	Typ	Max	Units
t <sub>PLH</sub>	Clock to Output	C <sub>L</sub> = 15pF R <sub>L</sub> = 2.0kΩ		13	20	ns
t <sub>PHL</sub>	Clock to Output			13	20	ns
t <sub>pw</sub>	Clock Pulse Width		17			ns
t <sub>s</sub>	Data		20			ns
t <sub>s</sub>	Enable		30			ns
t <sub>h</sub>	Data		5.0			ns
t <sub>h</sub>	Enable		5.0			ns
f <sub>max</sub> (Note 1)	Maximum Clock Frequency		40	65		MHz

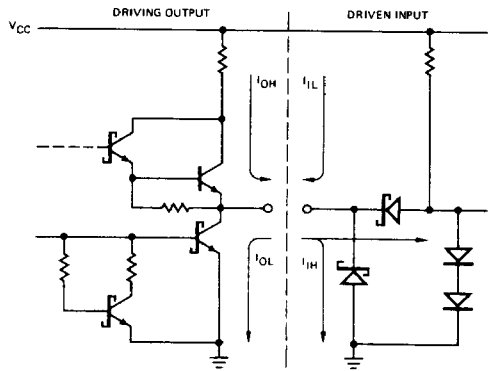
Note 1. Per industry convention, f<sub>max</sub> is the worst case value of the maximum device operating frequency with no constraints on t<sub>r</sub>, t<sub>f</sub>, pulse width or duty cycle.

### SWITCHING CHARACTERISTICS over operating range unless otherwise specified\*

Parameters	Description	Test Conditions	COMMERCIAL		MILITARY		Units
			Am25LS		Am25LS		
			Min	Max	Min	Max	
t <sub>PLH</sub>	Clock to Output	C <sub>L</sub> = 50pF R <sub>L</sub> = 2.0kΩ		30		35	ns
t <sub>PHL</sub>	Clock to Output			30		35	ns
t <sub>pw</sub>	Clock Pulse Width		26		30		ns
t <sub>s</sub>	Data		30		35		ns
t <sub>s</sub>	Enable		43		50		ns
t <sub>h</sub>	Data		11		12		ns
t <sub>h</sub>	Enable		11		12		ns
f <sub>max</sub> (Note 1)	Maximum Clock Frequency		30		25		MHz

\*AC performance over the operating temperature range is guaranteed by testing defined in Group A, Subgroup 9.

### LOW-POWER SCHOTTKY INPUT/OUTPUT CURRENT INTERFACE CONDITIONS



Note: Actual current flow direction shown.